











TPS3870-Q1

ZHCSK23A - JULY 2019 - REVISED SEPTEMBER 2019

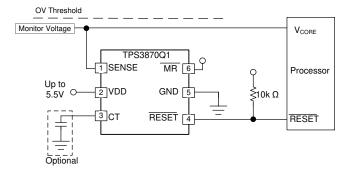
具有延时时间和手动复位功能的 TPS3870-Q1 过压复位 IC

1 特性

- 符合汽车类 应用要求
- 具有符合 AEC-Q100 标准的下列特性:
 - 器件温度等级 1: -40°C 至 +125°C 的环境工作 温度范围
 - 器件 HBM ESD 分类等级 2
 - 器件 CDM ESD 分类等级 C7B
- 输入电压范围: 1.7V 至 5.5V
- 欠压锁定 (UVLO): 1.7V
- 低静态电流: 7µA(最大值)
- 高阈值精度:
 - ±0.25% (典型值)
 - ±0.7% (-40°C 至 +125°C)
- 固定阈值电平
 - 50mV 阶跃(500mV 至 1.3V)
 - 1.5V、1.8V、2.5V、2.8V、2.9V、3.3V、5V
- 用户可调的电压阈值电平
- 内部毛刺抑制和迟滞
- 阶跃为 1% 时,公差介于 3% 至 7% 之间
- 固定延时时间选项: 50μs、1ms、5ms、10ms、 20ms、100ms、200ms
- 使用单个外部电容器的可编程延时时间选项
- 开漏低电平有效 OV 监控器
- RESET 电压锁存输出模式

2 应用

- 高级驾驶员辅助系统 (ADAS)
- 摄像头
- 传感器融合
- HEV/EV
- 基于 FPGA、ASIC 和 DSP 的系统 集成过压检测



3 说明

TPS3870-Q1 器件是一款集成式过压 (OV) 监控器或复位 IC,采用业界较小的 6 引脚 DSE 封装。这款高精度的电压监控器非常适合采用低电压电源轨的系统,并具有非常小的电源容差裕度。低阈值迟滞可防止在受监控的电压处于正常工作范围内时发出虚假复位信号。并且内置有毛刺抑制功能和噪声滤波器,进一步消除了错误信号所导致的错误复位。

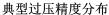
TPS3870-Q1 不需要使用任何外部电阻器来设置过压复位阈值,因此进一步优化了整体精度、成本、解决方案大小并提高了安全系统的可靠性。电容器时间 (CT) 引脚用于在每个器件的两个可用复位延时时间之间进行选择,还可以连接一个电容器以调整复位延时时间。单独的 SENSE 输入引脚和 VDD 引脚可实现高可靠性系统所需的冗余。

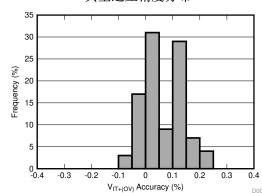
此器件的低典型静态电流规格为 4.5μA(典型值)。 TPS3870-Q1 适用于汽车 应用 , 符合 AEC-Q100 1 级标准。

器件信息(1)

器件型号	封装	封装尺寸 (标称值)
TPS3870-Q1	WSON (6)	1.50mm × 1.50mm

(1) 如需了解所有可用封装,请参阅数据表末尾的可订购产品附录。







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4 修订历史记录

注: 之前版本的页码可能与当前版本有所不同。

Changes from Original (July 2019) to Revision A

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• 将"预告信息"更改为"生产数据发布"....... 1



5 Device Comparison Table

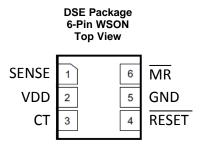
Table 1 shows the released versions of the TPS3870-Q1, including the nominal overvoltage thresholds. For all possible voltages, threshold tolerance, time delays, and threshold options, see 表 6. Contact TI sales representatives or on TI's E2E forum for details and availability of other options; minimum order quantities apply.

Table 1. Device Comparison Table

			THRESHOLD		
PART NUMBER	V _{MON}	CT Pin = Capacitor	CT Pin = Open	CT Pin = VDD	TOLERANCE
TPS3870J4080DSERQ1	0.80 V	Programmable	10 ms	200 ms	4%
TPS3870J4330DSERQ1	3.30 V	Programmable	10 ms	200 ms	4%



6 Pin Configuration and Functions



Pin Functions

	PIN	1/0	DESCRIPTION
NO.	NAME	I/O	DESCRIPTION
1	SENSE	I	Input for the monitored supply voltage rail. When the SENSE voltage goes above the overvoltage threshold, the RESET pin is driven low. Connect to VDD pin if monitoring VDD supply voltage.
2	VDD	I	Supply voltage input pin. Good analog design practice is to place a 0.1-μF ceramic capacitor close to this pin.
3	СТ	I	Capacitor time delay pin. The CT pin offers two fixed time delays by connecting CT pin to VDD or leaving it floating. Delay time can be programmed by connecting an external capacitor reference to ground.
4	RESET	0	Active-low, open-drain output. This pin goes low when the SENSE voltage rises above the internally overvoltage threshold (V _{IT+}). See the timing diagram in 🛭 19 for more details. Connect this pin to a pull-up resistor terminated to the desired pull-up voltage.
5	GND	_	Ground
6	MR	I	Manual reset (MR), pull this pin to a logic low ($V_{\overline{MR}_L}$) to assert a reset <u>signal</u> . After the \overline{MR} pin is deasserted the output goes high after the reset delay time(t_D) expires. \overline{MR} can be left floating when not in use.



Specifications

7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

		MIN	MAX	UNIT
Voltage	V_{DD}	-0.3	6	V
Voltage	V _{RESET}	-0.3	6	V
Voltage	V _{CT}	-0.3	6	V
Voltage	V _{SENSE}	-0.3	6	V
Voltage	V _{MR}	-0.3	6	V
Current	IRESET		±40	mA
	Continuous total power dissipation	See the Thermal Information		
Temperature (2)	Operating junction temperature, T _J	-40	150	°C
remperature V	Operating free-air temperature, T _A	-40	-0.3 6 -0.3 6 -0.3 6 -0.3 6 -0.3 6 -0.3 6 -0.3 16 -0.3 16 -0.3 16 -0.3 150 -40 150	°C
	Storage temperature, T _{stg}	-65	150	°C

Stresses beyond values listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

7.2 ESD ratings

				VALUE	UNIT
		Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1)		±2000	
V _(ESD)	Electrostatic discharge	Charged-device model (CDM), per AEC	All pins	±500	V
	alconargo	Q100-011	Corner pins	±750	

⁽¹⁾ AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification

7.3 Recommended Operating Conditions

		MIN	NOM MAX	UNIT
V_{DD}	Supply pin voltage	1.7	5.5	V
V _{SENSE}	Input pin voltage	0	5.5	V
V_{CT}	CT pin voltage (1) (2)		V_{DD}	V
V _{RESET}	Output pin voltage	0	5.5	V
$V_{\overline{MR}}$	MR pin Voltage (3)	0	5.5	V
I _{RESET}	Output pin current	0.3	10	mA
TJ	Junction temperature (free-air temperature)	-40	125	°C

As a result of the low dissipated power in this device, it is assumed that $T_J = T_A$.

CT pin connected to VDD pin requires a pullup resistor; 10 k Ω is recommended. The maximum rating is V_{DD} or 5.5 V, whichever is smaller. If the logic signal driving MR is less than V_{DD}, then additional current flows into V_{DD} and out of $\overline{\text{MR}}$.



7.4 Thermal Information

		TPS3870-Q1	
	THERMAL METRIC ⁽¹⁾	DSE (WSON)	UNIT
		PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	184.2	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	30.6	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	86.4	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	13.4	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	86.1	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	°C/W

⁽¹⁾ For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application

7.5 Electrical Characteristics

At 1.7 V \leq V_{DD} \leq 5.5 V, CT = $\overline{\text{MR}}$ = Open, $\overline{\text{RESET}}$ Voltage (V_{RESET}) = 10 k Ω to V_{DD}, $\overline{\text{RESET}}$ load = 10 pF, and over the operating free-air temperature range of – 40°C to 125°C, unless otherwise noted. Typical values are at T_J = 25°C, typical conditions at $V_{DD} = 3.3 \text{ V}$.

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{DD}	Supply Voltage		1.7		5.5	V
UVLO	Under Voltage Lockout ⁽¹⁾	V _{DD} falling below 1.7 V	1.2		1.7	V
V_{POR}	Power on reset voltage (2)	$V_{OL}(max) = 0.25 \text{ V}, I_{OUT} = 15 \mu\text{A}$			1	V
V _{IT+(OV)}	Positive- going threshold accuracy		-0.7	±0.25	0.7	%
V _{HYS}	Hysteresis Voltage ⁽³⁾		0.3	0.55	0.8	%
I _{DD}	Supply current	V _{DD} ≤ 5.5 V		4.5	7	μΑ
I _{SENSE}	Input current, SENSE pin	V _{SENSE} = 5 V		1	1.5	μΑ
		V _{DD} = 1.7 V, I _{OUT} = 0.4 mA			250	mV
V _{OL}	Low level output voltage	V _{DD} = 2 V, I _{OUT} = 3 mA			250	mV
		V _{DD} = 5 V, I _{OUT} = 5 mA			250	mV
I _{LKG}	Open drain output leakage current	$V_{DD} = V_{\overline{RESET}} = 5.5 \text{ V}$			300	nA
V_{MR_L}	MR logic low input				0.3	V
$V_{\overline{MR}_{-}H}$	MR logic high input		1.4			V
V _{CT_H}	High level CT pin voltage		1.4			V
R _{MR}	Manual reset Internal pullup resistance			100		ΚΩ
I _{CT}	CT pin charge current		337	375	413	nA
V _{CT}	CT pin comparator threshold voltage (4)		1.133	1.15	1.167	V

- $\overline{RESET} \ pin \ is \ driven \ low \ when \ V_{DD} \ falls \ below \ UVLO.$ $V_{POR} \ is \ the \ minimum \ V_{DD} \ voltage \ level \ for \ a \ controlled \ output \ state.$ $Hysteresis \ is \ with \ respect \ of \ the \ trip \ point \ (V_{IT+(OV)})$ $V_{CT} \ voltage \ refers \ to \ the \ comparator \ threshold \ voltage \ that \ measures \ the \ voltage \ level \ of \ the \ external \ capacitor \ at \ CT \ pin.$

7.6 Timing Requirements

At 1.7 V \leq V_{DD} \leq 5.5 V, CT = $\overline{\text{MR}}$ = Open, $\overline{\text{RESET}}$ Voltage (V_{RESET}) = 10 k Ω to V_{DD}, $\overline{\text{RESET}}$ load = 10 pF, and over the operating free-air temperature range of – 40°C to 125°C, unless otherwise noted. Typical values are at T_J = 25°C, typical conditions at $V_{DD} = 3.3 \text{ V}$.

			MIN	NOM	MAX	TINU
t_D	Reset time delay, TPS3870J	CT = Open	7	10	13	ms
t_D	Reset time delay, TPS3870J	$CT = 10 \text{ k}\Omega \text{ to } V_{DD}$	140	200	260	ms
t_{D}	Reset time delay, TPS3870K	CT = Open	0.7	1	1.3	ms
t_{D}	Reset time delay, TPS3870K	$CT = 10 \text{ k}\Omega \text{ to } V_{DD}$	14	20	26	ms
t_{D}	Reset time delay, TPS3870L	CT = Open	3.5	5	6.5	ms
t_D	Reset time delay, TPS3870L	$CT = 10 \text{ k}\Omega \text{ to } V_{DD}$	70	100	130	ms



Timing Requirements (continued)

At 1.7 V \leq V_{DD} \leq 5.5 V, CT = $\overline{\text{MR}}$ = Open, $\overline{\text{RESET}}$ Voltage (V_{RESET}) = 10 k Ω to V_{DD}, $\overline{\text{RESET}}$ load = 10 pF, and over the operating free-air temperature range of – 40° C to 125° C, unless otherwise noted. Typical values are at $T_J = 25^{\circ}$ C, typical conditions at $V_{DD} = 3.3 \text{ V}$.

			MIN	NOM	MAX	UNIT
t _D	Reset time delay, TPS3870M	$CT = 10 \text{ k}\Omega \text{ to V}_{DD}$ CT = Open		50		μs
t _{PD}	Propagation detect delay ⁽¹⁾⁽²⁾			15	30	μs
t _R	Output rise time (1)(3)			2.2		μs
t _F	Output fall time ⁽¹⁾⁽³⁾			0.2		μs
t _{SD}	Startup delay ⁽⁴⁾			300		μs
t _{GI (VIT+)}	Glitch Immunity overvoltage V _{IT+(OV)} , 5% Overdrive ⁽¹⁾			3.5		μs
t _{GI (MR)}	Glitch Immunity MR pin				25	ns
t _{PD (MR)}	Propagation delay from MR low to assert RESET			500		ns
t _{MR_W}	MR pin pulse width duration to assert RESET		1			μs
t _{D (MR)}	MR reset time delay			t _D		ms

- 5% Overdrive from threshold. Overdrive % = [V_{SENSE} $V_{IT+(OV)}$] / $V_{IT+(OV)}$ t_{PD} measured from threshold trip point $V_{IT+(OV)}$ to RESET V_{OL} voltage Output transitions from V_{OL} to 90% for rise times and 90% to V_{OL} for fall times.
- During the power-on sequence, V_{DD} must be at or above V_{DD} (MIN) for at least t_{SD} + t_D before the output is in the correct state.

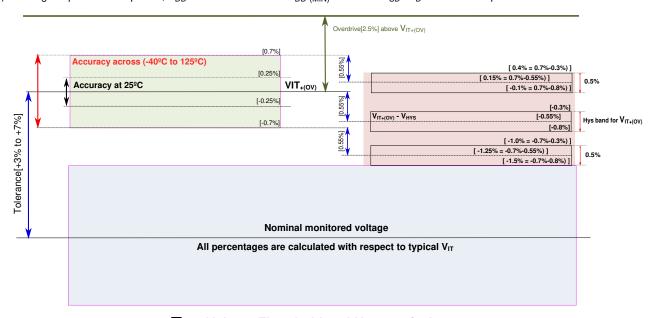
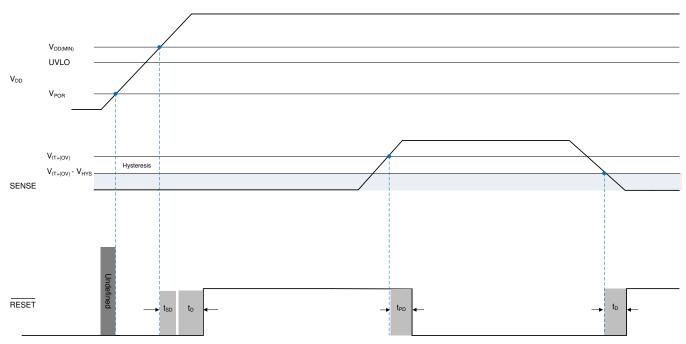


图 1. Voltage Threshold and Hysteresis Accuracy





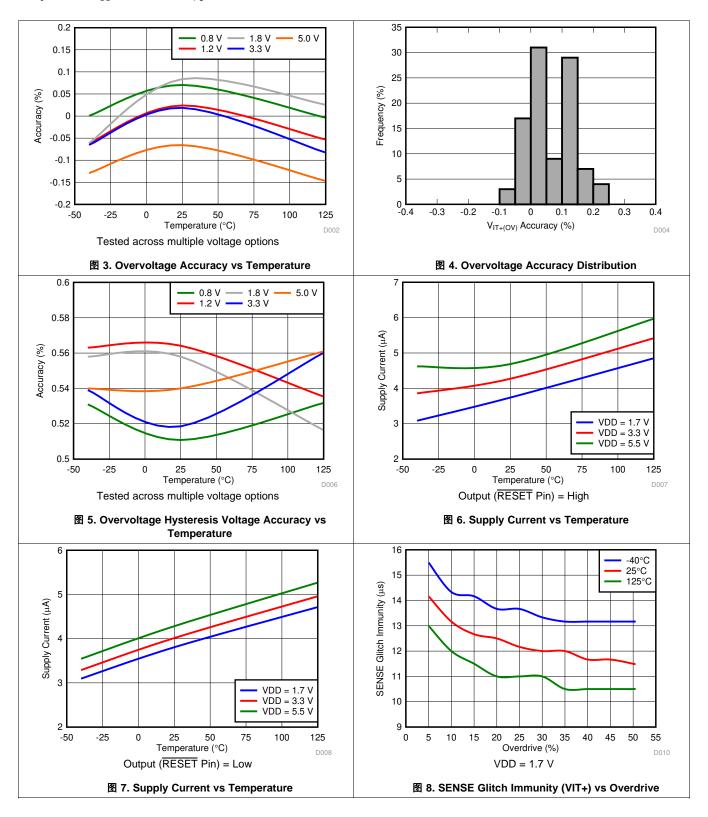
- (1) $V_{DD} = 2 \text{ V}$, $R_{PU} = 10 \text{ k}\Omega$ to V_{DD}
- (2) Variant M (time delay bypass) has a \sim 40 μ s pulse at $\overline{\text{RESET}}$ pin during power up window, this is present only when the power cycle off time is longer than 10 seconds, this behavior will not occur if SENSE pin is within window of operation during V_{DD} power up.

图 2. SENSE Timing Diagram



7.7 Typical Characteristics

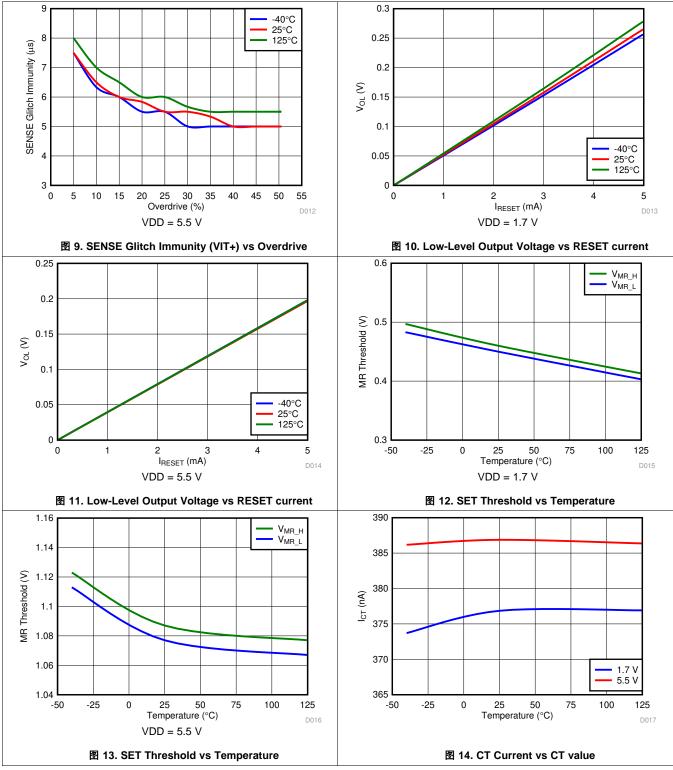
At T_J = 25°C, V_{DD} = 3.3 V, and R_{PU} = 10 k Ω , unless otherwise noted.



TEXAS INSTRUMENTS

Typical Characteristics (接下页)

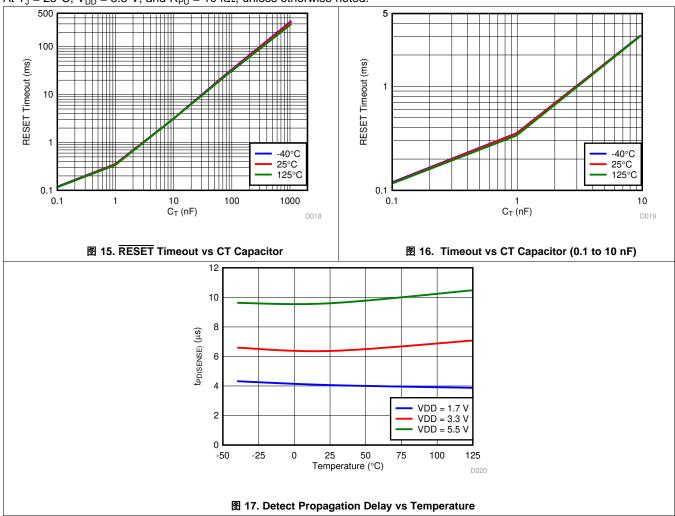
At T_J = 25°C, V_{DD} = 3.3 V, and R_{PU} = 10 k Ω , unless otherwise noted.





Typical Characteristics (接下页)







8 Detailed Description

8.1 Overview

The TPS3870-Q1 family of devices uses a voltage comparator and a precision voltage reference for overvoltage detection. The TPS3870-Q1 features a highly accurate threshold voltage (±0.7% over temperature) and a variety of voltage threshold variants.

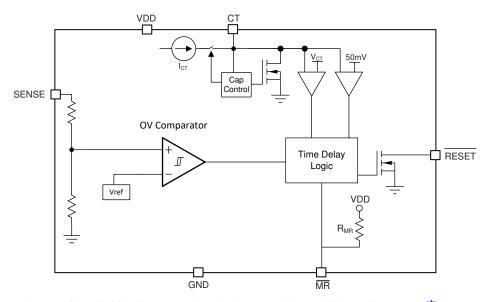
The TPS3870-Q1 includes the resistors used to set the overvoltage threshold internal to the device. These internal resistors allow for lower component counts and greatly simplifies the design because no additional margins are needed to account for the accuracy of external resistors.

TPS3870-Q1 versions J, K and L have three time delay settings, two fixed by connecting CT pin to VDD through a resistor and leaving CT floating and a programmable time delay setting that only requires a single capacitor connected from CT pin to ground.

Manual Reset (\overline{MR}) allows for sequencing or hard reset by driving the \overline{MR} pin below $V_{\overline{MR}}$ L.

The TPS3870-Q1 is designed to assert active low output signals when the monitored voltage is outside the safe window. The relationship between the monitored voltage and the states of the outputs is shown in $\frac{1}{5}$ 2.

8.2 Functional Block Diagram



*For all possible voltages, threshold tolerance, time delays, and threshold options, see 表 6.

8.3 Feature Description

8.3.1 VDD

The TPS3870-Q1 is designed to operate from an input voltage supply range between 1.7 V to 5.5 V. An input supply capacitor is not required for this device; however, if the input supply is noisy good analog practice is to place a $1-\mu F$ capacitor between the VDD pin and the GND pin.

V_{DD} needs to be at or above V_{DD(MIN)} for at least the start-up delay (t_{SD}+ t_D) for the device to be fully functional.

8.3.2 **SENSE**

The TPS3870-Q1 uses a comparator with a precision reference voltage and a trimmed resistor divider. This configuration optimizes device accuracy because all resistor tolerances are accounted for in the accuracy and performance specifications. The comparator also includes built-in hysteresis that provides noise immunity and ensures stable operation.



Feature Description (接下页)

Although not required in most cases, for noisy applications good analog design practice is to place a 1-nF to 10-nF bypass capacitor at the SENSE input in order to reduce sensitivity to transient voltages on the monitored signal.

When monitoring VDD supply voltage, the SENSE pin can be connected directly to VDD. The output (RESET) is high impedance when voltage at the SENSE pin is lower than the upper boundary of the threshold.

8.3.3 **RESET**

In a typical TPS3870-Q1 application, the $\overline{\text{RESET}}$ output is connected to a reset or enable input of a processor [such as a digital signal processor (DSP), application-specific integrated circuit (ASIC), or other processor type] or the enable input of a voltage regulator [such as a DC-DC converter or low-dropout regulator (LDO)].

The TPS3870-Q1 has an open drain active low output that requires a pull-up resistor to hold these lines high to the required voltage logic. Connect the pull-up resistor to the proper voltage rail to enable the output to be connected to other devices at the correct interface voltage levels. To ensure proper voltage levels, give some consideration when choosing the pull-up resistor values. The pull-up resistor value is determined by V_{OL} , output capacitive loading, and output leakage current. These values are specified in *Specifications*. The open drain output can be connected as a wired-OR logic with other open drain signals such as another TPS3870-Q1 RESET pin.

表 2 describes the scenarios when the output (RESET) is either asserted low or high impedance.

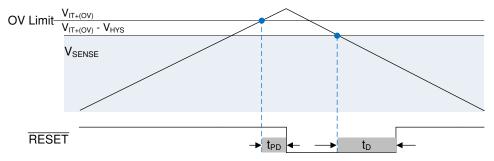


图 18. RESET output

8.3.4 Capacitor Time (CT)

The CT pin provides the user the functionality of both high-precision, factory-programmed, reset delay timing options and user-programmable, reset delay timing. The CT pin can be pulled up to V_{DD} through a resistor, have an external capacitor to ground, or can be left unconnected. The configuration of the CT pin is re-evaluated by the device every time the voltage on the SENSE line enters the valid window ($V_{SENSE} < V_{IT+(OV)}$). The pin evaluation is controlled by an internal state machine that determines which option is connected to the CT pin. The sequence of events takes 450 μ s to determine if the CT pin is left unconnected, pulled up through a resistor, or connected to a capacitor. If the CT pin is being pulled up to V_{DD} , then a pull-up resistor is required, 10 k Ω is recommended.

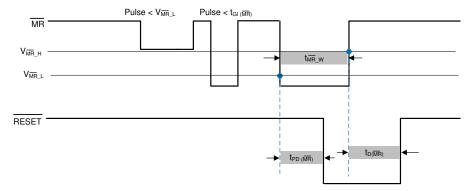
8.3.5 Manual Reset (MR)

The manual reset (\overline{MR}) input allows a processor or other logic circuits to initiate a reset. A logic low on \overline{MR} causes \overline{RESET} to assert. After \overline{MR} returns to a logic high and the SENSE \overline{pin} voltage is within a valid condition $(V_{SENSE} < V_{IT+(OV)})$, \overline{RESET} is deasserted after the reset delay time (t_D) . If \overline{MR} is not controlled externally, then \overline{MR} can either be connected to V_{DD} or left floating because the \overline{MR} pin is internally pulled up to V_{DD} . Figure \overline{RESET} .



Feature Description (接下页)





- (1) $\overline{\text{RESET}}$ pulls up to VDD with 10 k Ω .
- (2) To initiate and continue time reset counter both conditions must be met MR pin above V_{MR} or floating and V_{SENSE} below V_{IT+(OV)} V_{HYS}
- (3) MR is ignored during output RESET low event

图 19. Manual Reset Timing Diagram

8.4 Device Functional Modes

表 2. Functional Mode Truth Table

DESCRIPTION	CONDITION	MR PIN	VDD PIN	OUTPUT (RESET PIN)
Normal Operation	SENSE < V _{IT+(OV)}	Open or above V _{MR_H}	$V_{DD} > V_{DD(MIN)}$	High
Over Voltage detection	SENSE > V _{IT+(OV)}	Open or above V _{MR} _H	$V_{DD} > V_{DD(MIN)}$	Low
Manual reset	SENSE < V _{IT+(OV)}	Below V _{MR_L}	$V_{DD} > V_{DD(MIN)}$	Low
UVLO engaged	SENSE < V _{IT+(OV)}	Open or above V _{MR_H}	$V_{POR} < V_{DD} < UVLO$	Low

8.4.1 Normal Operation $(V_{DD} > V_{DD(MIN)})$

When the voltage on V_{DD} is greater than $V_{DD(MIN)}$ for approximately $(t_{SD}+t_{D})$, the \overline{RESET} output state will correspond to the \underline{SENSE} pin voltage with respect to the threshold limits, when SENSE voltage is outside of threshold limits the \overline{RESET} voltage will be low (V_{OL}) .

8.4.2 Undervoltage Lockout (V_{POR} < V_{DD} < UVLO)

When the <u>voltage</u> on V_{DD} is less than the device UVLO voltage but greater than the power-on reset voltage (V_{POR}) , the RESET pin will be held low, regardless of the voltage on SENSE pin.

8.4.3 Power-On Reset $(V_{DD} < V_{POR})$

When the voltage on V_{DD} is lower than the required voltage (V_{POR}) to internally pull the asserted output to GND, RESET signal is undefined and is not to be relied upon for proper device function.



9 Application and Implementation

注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

9.1.1 Voltage Threshold Accuracy

Voltage monitoring requirements vary depending on the voltage supply tolerance of the device being powered. Due to the high precision of the TPS3870-Q1 (±0.7% Max), the device allows for a wider supply voltage margins and threshold headroom for tight tolerance applications.

For example, take a DC/DC regulator providing power to a core voltage rail of an MCU. The MCU has a tolerance of ±5% of the nominal output voltage of the DC/DC. The user sets an ideal voltage threshold of 4% which allows for ±1% of threshold accuracy. Since the TPS3870-Q1 threshold accuracy is higher than ±1%, the user has more supply voltage margin which can allow for a relaxed power supply design. This gives flexibility to the DC/DC to use a smaller output capacitor or inductor because of a larger voltage window for voltage ripple and transients. There is also headroom between the minimum system voltage and voltage tolerance of the MCU to ensure that the voltage supply will never be in the region of potential failure of malfunction without the TPS3870-Q1 asserting a reset signal.

☑ 20 illustrates the supply overvoltage margin and accuracy of the TPS3870-Q1 for the example explained above. Using a low accuracy supervisor will eat into the available budget for the power supply ripple and transient response. This gives less flexibility to the user and a more stringent DC/DC converter design.

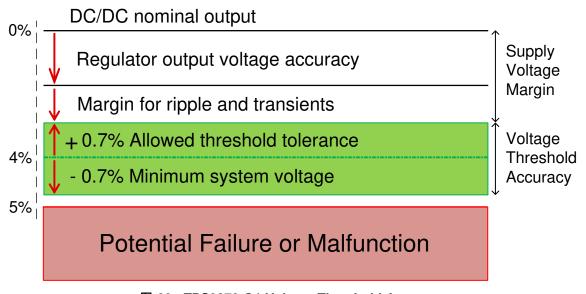


图 20. TPS3870-Q1 Voltage Threshold Accuracy



Application Information (接下页)

9.1.2 CT Reset Time Delay

The TPS3870-Q1 features three options for setting the reset delay (t_D): connecting a capacitor to the CT pin, connecting a pull-up resistor to VDD, and leaving the CT pin unconnected. 21 shows a schematic drawing of all three options. To determine which option is connected to the CT pin, an internal state machine controls the internal pulldown device and measures the pin voltage. This sequence of events takes 450 μ s to determine which timing option is used. Every time the voltage on the SENSE line enters the valid window ($V_{SENSE} < V_{IT+(OV)} - V_{HYS}$, the state machine determines the CT option.

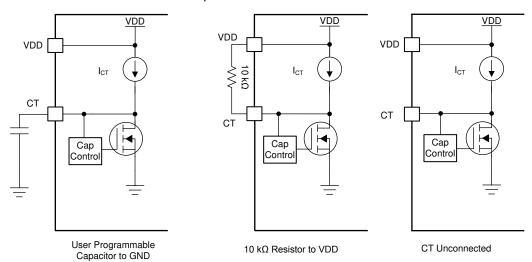


图 21. CT Charging Circuit

9.1.2.1 Factory-Programmed Reset Delay Timing

To use the factory-programmed timing options, the CT pin must either be left unconnected or pulled up to VDD through a 10 k Ω pull-up resistor. Using these options enables a high-precision reset delay timing, as shown in $\frac{1}{8}$ 3.

表 3. Reset Delay	Time for	Factory-Programmed	Reset Delay	Timing
------------------	----------	--------------------	-------------	--------

VARIANT	RESET DELAY TIME (t _D)							
	CT = Capacitor to GND	CT = Floating	$CT = 10 \text{ k}\Omega \text{ to VDD}$	VALUE				
TPS3870J	Programmable t _D	10	200	ms				
TPS3870K	Programmable t _D	1	20	ms				
TPS3870L	Programmable t _D	5	100	ms				
TPS3870M	N/A	50	50	μs				

9.1.2.2 Programmable Reset Delay-Timing

The TPS3870 reset time delay is based on internal current source (I_{CT}) to charge external capacitor (C_{CT}) and read capacitor voltage with the internal comparator. The minimum value capacitor is 250 pF. There is no limitation on maximum capacitor the only constrain is imposed by the initial voltage of the capacitor, if CT cap is zero or near to zero then ideally there is no other constraint on the max capacitor. The typical ideal capacitor value needed for a given delay time can be calculated using $\Delta \vec{x}$ 1, where C_{CT} is in nanofarads (nF) and t_D is in ms:

$$t_D = 3.066 \times C_{CT} + 0.5 \text{ ms}$$
 (1)

To calculate the minimum and maximum-reset delay time use 公式 2 and 公式 3, respectively.

$$t_{D(min)} = 2.7427 \times C_{CT} + 0.3 \text{ ms}$$
 (2)

$$t_{D(max)} = 3.4636 \times C_{CT} + 0.7 \text{ ms}$$
 (3)



The slope of the equation is determined by the time the CT charging current (I_{CT}) takes to charge the external capacitor up to the CT comparator threshold voltage ($\underline{V_{CT}}$). When RESET is asserted, the capacitor is discharged through the internal CT pulldown resistor. When the RESET conditions are cleared, the internal precision current source is enabled and begins to charge the external capacitor; when $\underline{V_{CT}} = 1.15 \text{ V}$, RESET is unasserted. Note that in order to minimize the difference between the calculated RESET delay time and the actual RESET delay time, use a use a high-quality ceramic dielectric COG, X5R, or X7R capacitor and minimize parasitic board capacitance around this pin. $\underline{\mathfrak{F}}$ 4 lists the reset delay time ideal capacitor values for C_{CT} .

4. Reset Belly Time for Ideal Supulific Values						
ССТ	RESET DELAY TIME (t _D), TYPICAL					
250 pF	1.27 ms					
1 nF	3.57 ms					
3.26 nF	10.5 ms					
32.6 nF	100.45 ms					
65.2 nF	200.40 ms					
1uF	3066 50 mg					

表 4. Reset Delay Time for Ideal Capacitor Values

9.1.3 RESET Latch Mode

The TPS3870-Q1 features a voltage latch mode on the $\overline{\text{RESET}}$ pin when connecting the CT pin to common ground. A pull-down resistor is recommended to limit current consumption of the system. In latch mode, if the RESET pin is low or triggers low, the pin will stay low regardless if V_{SENSE} is within the acceptable voltage boundaries ($V_{\text{SENSE}} < V_{\text{IT+(OV)}}$). To unlatch the device provide a voltage to the CT pin that is greater than the CT pin comparator threshold voltage, V_{CT} . The $\overline{\text{RESET}}$ pin will trigger high instantaneously without any reset delay. A voltage greater than 1.2 V to recommended to ensure a proper unlatch. Use a series resistance to limit current when an unlatch voltage is applied. For more information, Design 1: $\overline{\text{RESET}}$ Latch Mode gives an example of a typical latch application.

注

At power up, the TPS3870-Q1 will be latched when CT is connected to GND. To ensure correct power up when using RESET latch mode, send a pulse to the CT pin greater than 1.2 V after t_{SD} and SENSE is within the correct window of operation.

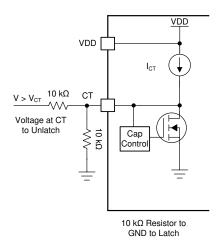


图 22. RESET Latch Circuit



9.1.4 Adjustable Voltage Thresholds

The TPS3870-Q1 0.7% maximum accuracy allows for adjustable voltage thresholds using external resistors without adding major inaccuracies to the device. In case that the desired monitored voltage is not available, external resistor dividers can be used to set the desired voltage thresholds. ₹ 23 illustrates an example of how to adjust the voltage threshold with external resistor dividers. The resistors can be calculated depending on the desired voltage threshold and device part number. TI recommends using the 0.8V voltage threshold device such as the TPS3870J4080 because of the bypass mode of internal resistor ladder.

For example, consider a 2.0 V rail being monitored (V_{MON}) using the TPS3870J4080 variant. Using $\Delta \pm 4$, R1 = 15 kΩ given that R2 = 10 kΩ, V_{MON} = 2 V , and V_{SENSE} = 0.8 V. This device is typically meant to monitor a 0.8 V rail with a +4% voltage threshold. This means that the device overvoltage threshold ($V_{IT+(OV)}$) is 0.832 V. Using $\Delta \pm 4$, the monitored overvoltage threshold (V_{MON+}) = 2.08 V when V_{SENSE} = $V_{IT+(OV)}$. If a wider tolerance threshold is desired, use a device variant shown on ± 6 to determine what device part number matches your application.

$$V_{SENSE} = V_{MON} \times (R_2 \div (R_1 + R_2)) \tag{4}$$

There are inaccuracies that must be taken into consideration while adjusting voltage thresholds. Aside from the tolerance of the resistor divider, there is an internal resistance of the SENSE pin that may affect the accuracy of the resistor divider. Although expected to be very high impedance, users are recommended to calculate the values for design specifications. The internal sense resistance (R_{SENSE}) can be calculated by the sense voltage (V_{SENSE}) divided by the sense current (I_{SENSE}) as shown in \triangle 6. V_{SENSE} can be calculated using \triangle 3 depending on the resistor divider and monitored voltage. I_{SENSE} can be calculated using \triangle 5.

$$I_{SENSE} = (V_{MON} - V_{SENSE}) \div R_1 - (V_{SENSE} \div R_2)$$
(5)

$$R_{SENSE} = V_{SENSE} \div I_{SENSE}$$
 (6)

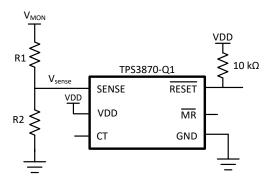


图 23. Adjustable Voltage Threshold with External Resistor Dividers

Although 公式 4 solves for V_{SENSE} , inaccuracies for leakage need to be taken into consideration when understanding the overall threshold accuracy of the device. To calculate the threshold with this inaccuracy taken into account, use 公式 7

$$V_{\text{IT_Actual}} = V_{\text{SENSE}} + R_1 \times ((V_{\text{SENSE}} \div R_2) + I_{\text{SENSE}})$$
 (7)

To calculate the worst case values through the resistor divider, I_{SENSE} should be taken from the Electrical Characteristics table. While these equations provide a summary of what you need to correctly account for factors that go into determining your resistor divider with inaccuracy, you should use the Application Report Optimizing Resistor Dividers at a Comparator Input to further understand this and to design your implementation. This report explains how to optimize the resistor divider at the SENSE input for an adjustable voltage threshold version of the device. You should follow this Application Report using 0.8 V as the V_{REF} value for the TPS3870-Q1.



9.1.5 Immunity to SENSE Pin Voltage Transients

The TPS3870-Q1 is immune to short voltage transient spikes on the input pins. Sensitivity to transients depends on both transient duration and overdrive (amplitude) of the transient.

Overdrive is defined by how much the V_{SENSE} exceeds the specified threshold, and is important to know because the smaller the overdrive, the slower the response of the outputs (RESET). Threshold overdrive is calculated as a percent of the threshold in question, as shown in 公式 8:

Overdrive % = $| (V_{SENSE} - (V_{IT+(OV)})) / V_{IT} (Nominal) \times 100\% |$

where:

- V_{SENSE} is the voltage at the SENSE pin
- V_{IT} (Nominal) is the nominal threshold voltage
- V_{IT+(OV)} represents the actual overvoltage tripping voltage

(8)

9.1.5.1 Hysteresis

The overvoltage comparator includes built-in hysteresis that provides noise immunity and ensures stable operation. For example if the voltage on the SENSE pin goes above $V_{IT+(OV)}$ and \overline{RESET} is asserted (driven low), then when the voltage on the SENSE pin is below the positive threshold voltage, RESET deasserts after the user-defined RESET delay time. Figure 24 shows the relation between V_{IT+(OV)} and hysteresis voltage (V_{HYS}).

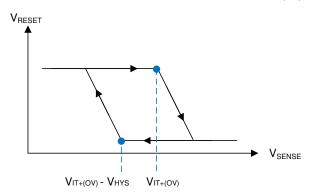


图 24. SENSE Pin Hysteresis



9.2 Typical Application

9.2.1 Design 1: RESET Latch Mode

Another typical application for the TPS3870-Q1 is shown in 25. The TPS3870-Q1 is used in a RESET latch output mode. In latch mode, once RESET driven logic low, it will stay low regardless of the sense voltage. If the RESET pin is low on start up, it will also stay low regardless of sense voltage.

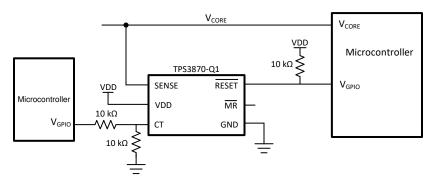


图 25. Window Voltage Monitoring with RESET Latch

9.2.1.1 Design Requirements

表 5. Design Parameters

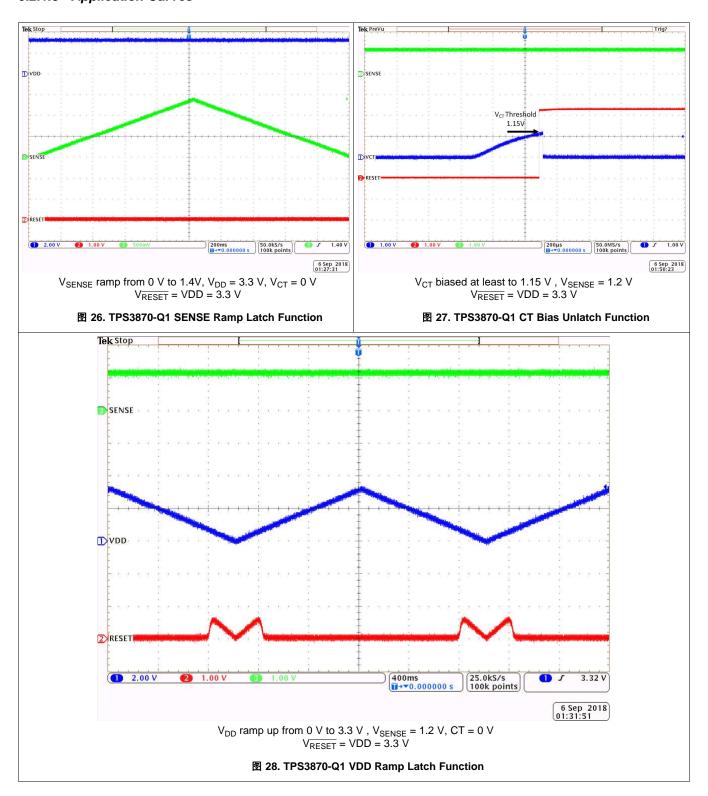
PARAMETER	DESIGN REQUIREMENT	DESIGN RESULT
Monitored Rail	1.2-V _{CORE} nominal, with alerts if outside of 5% of 1.2 V (including device accuracy), Latch when RESET is low, until voltage is applied on CT pin.	Worst case V _{IT+(OV)} = 1.256 V (4.7%),
Output logic voltage	5-V CMOS	5-V CMOS
Maximum device current consumption	15 µA	4.5 μA (Typ), 7 μA (Max)

9.2.1.2 Detailed Design Procedure

The $\overline{\text{RESET}}$ pin can be latched when the CT pin is connected to a common ground with a pull-down resistor. A 10 k Ω resistors is recommended to limit current consumption. To unlatch the device provide a voltage to the CT pin that is greater than the CT pin comparator threshold voltage, V_{CT} . A voltage greater than 1.15 V to recommended to ensure a proper unlatch. Use a series resistance to limit current when an unlatch voltage is applied. To go back into latch operation, disconnect the voltage on the CT pin. The $\overline{\text{RESET}}$ pin will trigger high instantaneously without any reset delay.



9.2.1.3 Application Curves





10 Power Supply Recommendations

10.1 Power Supply Guidelines

This device is designed to operate from an input supply with a voltage range between 1.7 V to 5.5 V. It has a 6-V absolute maximum rating on the VDD pin. It is good analog practice to place a 0.1-µF to 1-µF capacitor between the VDD pin and the GND pin depending on the input voltage supply noise. If the voltage supply providing power to VDD is susceptible to any large voltage transient that exceed maximum specifications, additional precautions must be taken. See SNVA849 for more information.

11 Layout

11.1 Layout Guidelines

- Place the external components as close to the device as possible. This configuration prevents parasitic errors from occurring.
- Avoid using long traces for the VDD supply node. The VDD capacitor, along with parasitic inductance from the supply to the capacitor, can form an LC circuit and create ringing with peak voltages above the maximum VDD voltage.
- Avoid using long traces of voltage to the sense pin. Long traces increase parasitic inductance and cause inaccurate monitoring and diagnostics.
- Do not run sensitive analog traces in parallel with digital traces. Avoid crossing digital and analog traces if possible, and only make perpendicular crossings when absolutely necessary.

11.2 Layout Example

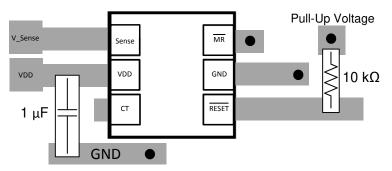


图 29. Recommended Layout



12 器件和文档支持

12.1 器件命名规则

表 6 显示了如何根据器件型号来解译器件的功能。

表 6. 器件命名约定

说明		命名规则	值		
		TPS3870	TPS3870		
延时时间选项:每个器件都有两个		J	CT 引脚断开 = 10ms, CT 引脚连接到 VDD = 200ms 可使用外部电容器对 CT 进行编程		
	k∏ OV	К	CT 引脚断开 = 1ms, CT 引脚连接到 VDD = 20ms 可使用外部电容器对 CT 进行编程		
固定延时时间,而且可以通过外部 电容器器件型号来调节延迟选项	仅 OV	L	CT 引脚断开 = 5ms, CT 引脚连接到 VDD = 100ms 可使用外部电容器对 CT 进行编程		
		М	CT 引脚断开 = 50μs,CT 引脚连接到 VDD = 50μs 无法对 CT 进行编程		
		3	来自标称值的过压阈值 = OV: 3%		
A VALUE AND LESS DATE OF THE		4	来自标称值的过压阈值 = OV: 4%		
容差选项: 触发电压或以上述阈值时形式表示的阈值电压	电压自分比	5	来自标称值的过压阈值 = OV: 5%		
702(407)1178 直飞星		6	来自标称值的过压阈值 = OV: 6%		
		7	来自标称值的过压阈值 = OV: 7%		
标称监控器阈值电压选项		050	0.50V		
		055	0.55V		
		060	0.60V		
		065	0.65V		
		070	0.70V		
		075	0.75V		
		080	0.80V		
		085	0.85V		
		090	0.90V		
		095	0.95V		
		100	1.00V		
		105	1.05V		
		110	1.10V		
		115	1.15V		
		120	1.20V		
		125	1.25V		
		130	1.30V		
		150	1.50V		
		180	1.80V		
		250	2.50V		
		280	2.80V		
		290	2.90V		
		330	3.30V		
		500	5.00V		
封装		DSE	WSON - 6 引脚 (1.5mm × 1.5mm)		
卷带		R	大卷带		
汽车版本		Q1	Q100 AEC		



12.2 文档支持

12.2.1 评估模块

评估模块 (EVM) 可与 TPS3870-Q1 配套使用,帮助评估初始电路性能。适用于 TPS3703-Q1 的 EVM 可用于对 TPS3870-Q1 仅进行过压评估。*TPS3703-Q1 评估模块*(以及*相关的用户指南*)可在德州仪器 (TI) 网站上的产品文件夹中获取,也可直接从 TI 网上商店购买。

12.3 接收文档更新通知

要接收文档更新通知,请导航至 ti.com. 上的器件产品文件夹。单击右上角的通知我进行注册,即可每周接收产品信息更改摘要。有关更改的详细信息,请查看任何已修订文档中包含的修订历史记录。

12.4 支持资源

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ESD 的损坏小至导致微小的性能降级,大至整个器件故障。 精密的集成电路可能更容易受到损坏,这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

12.7 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

13 机械、封装和可订购信息

以下页面包含机械、封装和可订购信息。这些信息是指定器件的最新可用数据。数据如有变更,恕不另行通知,且不会对此文档进行修订。如需获取此数据表的浏览器版本,请查阅左侧的导航栏。



PACKAGE OPTION ADDENDUM

10-Dec-2020

PACKAGING INFORMATION

www.ti.com

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
TPS3870J4080DSERQ1	ACTIVE	WSON	DSE	6	3000	RoHS & Green	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	H5	Samples
TPS3870J4330DSERQ1	ACTIVE	WSON	DSE	6	3000	RoHS & Green	NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	H4	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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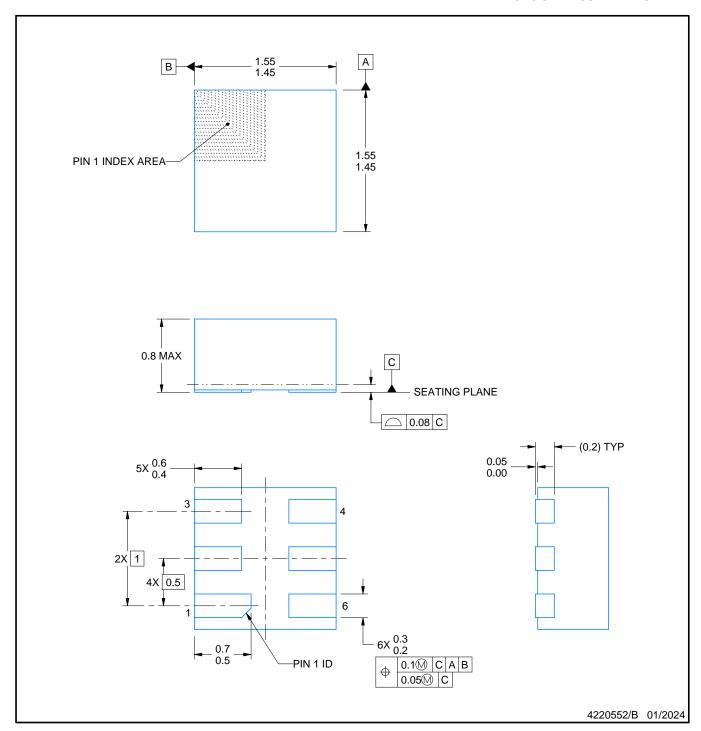




10-Dec-2020



PLASTIC SMALL OUTLINE - NO LEAD



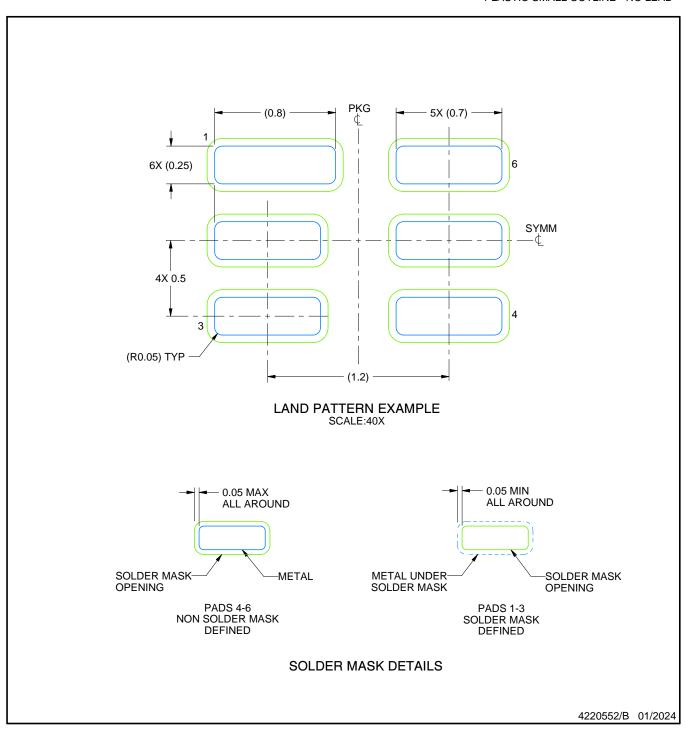
NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.



PLASTIC SMALL OUTLINE - NO LEAD

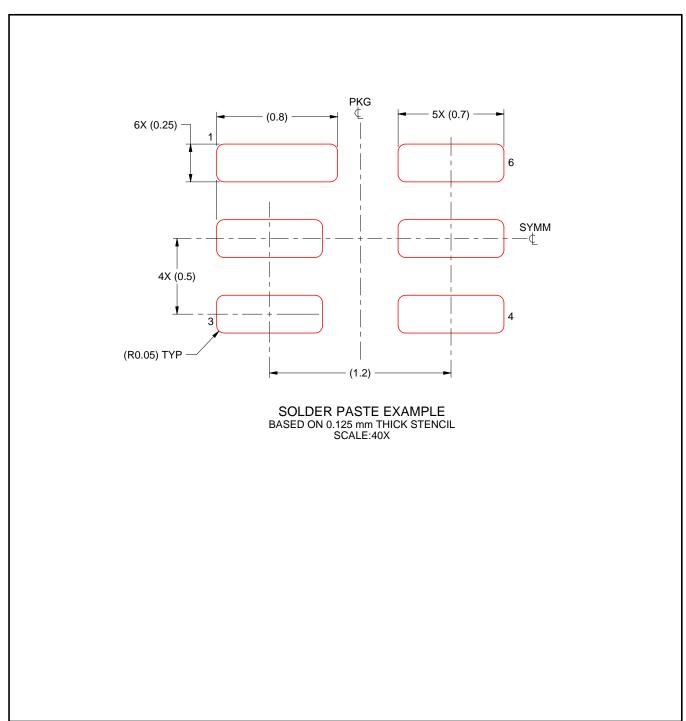


NOTES: (continued)

3. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).



PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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